

Search Notes**Application/Control No.**

10/644,804

Examiner

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Applicant(s)/Patent under Reexamination

CHEN, CHIH-JU

Art Unit

2111

SEARCHED

Class	Subclass	Date	Examiner
710	300-303,62,74,313,316	8/23/2005	GCR
711	100,103	8/23/2005	GCR
361	684,686	8/23/2005	GCR
361	737	8/23/2005	GCR
439	59,79,945	8/23/2005	GCR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	8/22/2005	GCR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	8/23/2005	GCR
EAST: USPT (see search history printouts)	8/22/2005	GCR
NPL: IEEE Xplore see search history printouts)	8/22/2005	GCR